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**Non-destructive testing — Acoustic  
emission inspection — Vocabulary**

*Essais non destructifs — Contrôle par émission acoustique — Vocabulaire*

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## Foreword

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International Standard ISO 12716 was prepared by Technical Committee ISO/TC 135, *Non-destructive testing*, Subcommittee SC 3, *Acoustical methods*.

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## Introduction

This International Standard is a compilation of terms to provide a precise understanding or interpretation of acoustic emission inspection. These terms serve to secure the foundation of acoustic emission technology growth within the academic and industrial communities.

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# Non-destructive testing — Acoustic emission inspection — Vocabulary

## 1 Scope

This International Standard defines the terminology that is used in acoustic emission inspection and forms a common basis for standards and general use.

## 2 Terms and definitions

### 2.1

#### acoustic emission

##### AE

class of phenomena whereby transient elastic waves are generated by the rapid release of energy from localized sources within a material, or the transient waves so generated

NOTE Acoustic emission is the recommended term for general use. Other terms that have been used in AE literature include:

- a) stress wave emission;
- b) microseismic activity;
- c) emission or acoustic emission with other qualifying modifiers.

### 2.2

#### acousto-ultrasonics

##### AU

nondestructive examination method that uses induced stress waves to detect and assess diffuse defect states, damage conditions and variations of mechanical properties of a test structure combining aspects of acoustic emission (AE) signal analysis with ultrasonic materials characterization techniques

### 2.3

#### AE signal duration

time interval between AE signal start and AE signal end

### 2.4

#### AE signal end

recognized termination of an AE signal, usually defined as the last crossing of the threshold by that signal

### 2.5

#### AE signal generator

device which can repeatedly induce a specified transient signal into an AE instrument

### 2.6

#### AE signal rise time

time interval between AE signal start and the peak amplitude of that AE signal

**2.7**

**AE signal start**

beginning of an AE signal as recognized by the system processor, usually defined by an amplitude excursion exceeding threshold

**2.8**

**array**

group of two or more AE sensors positioned on a structure for the purposes of detecting and locating sources that would normally be within the array

**2.9**

**attenuation**

decrease in AE amplitude per unit distance, normally expressed in dB per unit length

**2.10**

**average signal level**

rectified, time-averaged AE logarithmic signal, measured on the AE amplitude logarithmic scale and reported in dB<sub>AE</sub> units (where 0 dB<sub>AE</sub> refers to 1 μV at the preamplifier input)

**2.11**

**channel, acoustic emission**

acoustic emission channel

assembly of a sensor, preamplifier or impedance matching transformer, filters, secondary amplifier or other instrumentation as needed, connecting cables, and detector or processor

NOTE A channel for examining fiberglass reinforced plastic (FRP) may utilize more than one sensor with associated electronics. Channels may be processed independently or in predetermined groups having similar sensitivity and frequency characteristics.

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**2.12**

**count, acoustic emission**

acoustic emission count

count, ring-down

ring-down count

emission count

$N$

number of times the acoustic emission signal exceeds a preset threshold during any selected portion of a test

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**2.13**

**count, event**

event count

$N_e$

number obtained by counting each discerned acoustic emission event once

**2.14**

**count rate, acoustic emission**

acoustic emission count rate

emission rate

count rate

$\dot{N}$

time rate at which emission counts occur

**2.15**

**couplant**

material used at the structure-to-sensor interface to improve the transmission of acoustic energy across the interface during acoustic emission monitoring

**2.16**dB<sub>AE</sub>

logarithmic measure of acoustic emission signal amplitude, referenced to 1 µV

Signal peak amplitude (dB<sub>AE</sub>) =  $20 \log_{10}(A_1/A_0)$ 

where

 $A_0$  is equal to 1 µV at the sensor output (before amplification); $A_1$  is the peak voltage of the measured acoustic emission signal.

Acoustic emission reference scale:

dB <sub>AE</sub> value	Voltage at sensor output
0	1 µV
20	10 µV
40	100 µV
60	1 mV
80	10 mV
100	100 mV

**2.17****dead time**

instrumentation dead time

any interval during data acquisition when the instrument or system is unable to accept new data for any reason

**2.18****distribution, amplitude, cumulative (acoustic emission)**

cumulative (acoustic emission) amplitude distribution

 $F(V)$ number of acoustic emission events with signals that exceed an arbitrary amplitude as a function of amplitude  $V$ **2.19****distribution, threshold crossing, cumulative (acoustic emission)** $F_t(V)$ 

cumulative (acoustic emission) threshold crossing distribution

number of times the acoustic emission signal exceeds an arbitrary threshold as a function of the threshold voltage  $V$ **2.20****distribution, differential (acoustic emission) amplitude**

differential (acoustic emission) amplitude distribution

 $f(V)$ number of acoustic emission events with signal amplitudes between amplitudes of  $V$  and  $V + \Delta V$  as a function of the amplitude  $V$  where  $f(V)$  is the absolute value of the derivative of the cumulative amplitude distribution  $F(V)$ **2.21****distribution, differential (acoustic emission) threshold crossing**

differential (acoustic emission) threshold crossing distribution

 $f_t(V)$ number of times the acoustic emission signal waveform has a peak between thresholds  $V$  and  $V + \Delta V$  as a function of the threshold  $V$  where  $f_t(V)$  is the absolute value of the derivative of the cumulative threshold crossing distribution  $F_t(V)$

**2.22**

**distribution, logarithmic (acoustic emission) amplitude**

logarithmic (acoustic emission) amplitude distribution

$g(V)$

number of acoustic emission events with signal amplitudes between  $V$  and  $\alpha V$  (where  $\alpha$  is a constant multiplier) as a function of the amplitude

NOTE This is a variant of the differential amplitude distribution, appropriate for logarithmically windowed data.

**2.23**

**dynamic range**

difference, in decibels, between the overload level and the minimum signal level (usually fixed by one or more of the noise levels, low-level distortion, interference or resolution level) in a system or sensor

**2.24**

**effective velocity**

velocity calculated on the basis of arrival times and propagation distances determined by artificial AE generation and used for computed location

**2.25**

**emission, burst**

burst emission

qualitative description of the discrete signal related to an individual emission event occurring within the material

NOTE Use of the term "burst emission" is recommended only for describing the qualitative appearance of emission signals. Figure 1 shows an oscilloscope trace of burst emission at two different sweep rates.

**2.26**

**emission, continuous**

continuous emission

qualitative description of the sustained signal level produced by rapidly occurring acoustic emission events

NOTE Use of the term "continuous emission" is recommended only for describing the qualitative appearance of emission signals. Figure 2 shows oscilloscope traces of a continuous emission signal at two different sweep rates.

**2.27**

**energy, acoustic emission event**

acoustic emission event energy

total elastic energy released by an emission event

**2.28**

**evaluation threshold**

threshold value used for analysis of the examination data

NOTE Data may be recorded with a system examination threshold lower than the evaluation threshold. For analysis purposes, dependence of measured data on the system examination threshold must be taken into consideration.

**2.29**

**event, acoustic emission (emission event)**

acoustic emission event

local material change giving rise to acoustic emission

**2.30**

**examination area**

that portion of a structure being monitored using acoustic emission

**2.31**

**examination region**

that portion of the test article evaluated using acoustic emission technology



**2.32****Felicity effect**

presence of detectable acoustic emission at a fixed predetermined sensitivity level at stress levels below those previously applied

**2.33****Felicity ratio**

ratio of the stress at which the Felicity effect occurs to the previously applied maximum stress

NOTE The fixed sensitivity level will usually be the same as was used for the previous loading or test.

**2.34****floating threshold**

any threshold with amplitude established by a time average measure of the input signal

**2.35****hit**

any signal that exceeds the threshold and causes a system channel to accumulate data

**2.36****interval, arrival time**

arrival time interval

$\Delta t_{ij}$

time interval between the detected arrivals of an acoustic emission wave at the  $i$ th and  $j$ th sensors of a sensor array

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**2.37****Kaiser effect**

absence of detectable acoustic emission at a fixed sensitivity level, until previously applied stress levels are exceeded

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**2.38****location, cluster**

location method based upon a specified amount of AE activity located within a specified length or area, e.g. 5 events within 12 linear units (e.g. cm) or 12 square units (e.g. cm<sup>2</sup>)

**2.39****location, computed**

adaptive location

source location method based on algorithmic analysis of the difference in arrival times among sensors

NOTE Several approaches to computed location are used, including linear location, planar location, three dimensional location and adaptive location.

**2.39.1****linear location**

one-dimensional source location requiring two or more channels

**2.39.2****planar location**

two-dimensional source location requiring three or more channels

**2.39.3****3-D location**

three-dimensional source location requiring five or more channels

**2.39.4****adaptive location**

source location by iterative use of simulated sources in combination with computed location